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Inventor Name Search Result

Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
06633888	4568032	150	07/24/1984	WINDING APPARATUS	ISHIDA, MASAHIRO
06691908	4674028	150	01/16/1985	IDENTIFICATION METHOD OF A PROCESS PARAMETER	ISHIDA, MASAHIRO
06798025	4694999	150	11/14/1985	TOROIDAL WINDING APPARATUS	ISHIDA, MASAHIRO
06799741	4688733	150	11/19/1985	TOROIDAL CORE WINDING APPARATUS	ISHIDA, MASAHIRO
06805208	4691872	150	12/05/1985	TOROIDAL WINDING APPARATUS	ISHIDA, MASAHIRO
06888202	4817032	150	07/23/1986	USER PROGRAMMABLE DATA PROCESSOR	ISHIDA, MASAHIRO
07333587	4988047	150	04/05/1989	WINDING APPARATUS	ISHIDA, MASAHIRO
07436627	Not Issued	166	11/15/1989	POLYURETHANE-UREA RESIN	ISHIDA, MASAHIRO
07758207	Not Issued	161	09/12/1991	POLYURETHANE-UREA RESIN	ISHIDA, MASAHIRO
07875019	5355009	150	04/28/1992	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING SAME	ISHIDA, MASAHIRO
07916666	5319234	250	07/22/1992	C-BICMOS SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
07970828	Not Issued	161	11/03/1992	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING SAME	ISHIDA, MASAHIRO
08037141	5350939	150	03/25/1993	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THEREOF	ISHIDA, MASAHIRO
08260428	Not Issued	166	06/15/1994	SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO

<u>08273915</u>	5480816	150	07/12/1994	METHOD OF FABRICATING A BIPOLEAR TRANSISTOR HAVING A LINK BASE	ISHIDA, MASAHIRO
<u>08310526</u>	5471085	150	09/22/1994	SEMICONDUCTOR DEVICE WITH POLYCRYSTALLINE SILICON Emitter CONDUCTIVE LAYER	ISHIDA, MASAHIRO
<u>08351144</u>	Not Issued	166	11/29/1994	STATIC SEMICONDUCTOR MEMORY DEVICE	ISHIDA, MASAHIRO
<u>08523963</u>	5584750	150	09/06/1995	POLISHING MACHINE WITH DETACHABLE SURFACE PLATE	ISHIDA, MASAHIRO
<u>08564520</u>	5655954	150	11/29/1995	POLISHING APPARATUS	ISHIDA, MASAHIRO
<u>08651244</u>	5849119	250	05/22/1996	PNEUMATIC TIRE INCLUDING ZIG-ZAG SUBGROOVES	ISHIDA, MASAHIRO
<u>08668526</u>	5717240	250	06/28/1996	STATIC SEMICONDUCTOR MEMORY DEVICE	ISHIDA, MASAHIRO
<u>08693497</u>	5619056	150	08/07/1996	SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>08810786</u>	5841153	150	03/05/1997	AN SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>08905048</u>	Not Issued	161	08/01/1997	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09056500</u>	6069394	150	04/08/1998	SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	ISHIDA, MASAHIRO
<u>09116245</u>	5994719	150	07/16/1998	A SRAM SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>09151756</u>	6242806	250	09/11/1998	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THEREOF	ISHIDA, MASAHIRO
<u>09194220</u>	6661839	150	11/20/1998	METHOD AND DEVICE FOR COMPRESSING AND EXPANDING DATA PATTERN	ISHIDA, MASAHIRO
<u>09227936</u>	6180986	150	01/11/1999	SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE	ISHIDA, MASAHIRO

				SAME	
<u>09246458</u>	6621860	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<u>09251096</u>	6291979	150	02/16/1999	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT	ISHIDA, MASAHIRO
<u>09259328</u>	6198139	150	03/01/1999	A COMPLEMENTARY MOS DEVICE	ISHIDA, MASAHIRO
<u>09285648</u>	6249534	150	04/05/1999	NITRIDE SEMICONDUCTOR LASER DEVICE	ISHIDA, MASAHIRO
<u>09289960</u>	6339014	150	04/13/1999	METHOD FOR GROWING NITRIDE COMPOUND SEMICONDUCTOR	ISHIDA, MASAHIRO
<u>09317604</u>	6218207	150	05/25/1999	METHOD FOR GROWING NITRIDE SEMICONDUCTOR CRYSTALS, NITRIDE SEMICONDUCTOR DEVICE, AND METHOD FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09389024</u>	6117700	150	09/02/1999	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE HAVING GROUP III NITRIDE	ISHIDA, MASAHIRO
<u>09392376</u>	6563140	150	09/09/1999	SEMICONDUCTOR LIGHT EMITTING DEVICE	ISHIDA, MASAHIRO
<u>09395261</u>	6617182	150	09/14/1999	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09408280</u>	6687629	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<u>09416523</u>	6221050	150	10/12/1999	SELF-RETAINING NEEDLE ASSEMBLY AND VALVE ELEMENT FOR USE THEREIN	ISHIDA, MASAHIRO
<u>09494321</u>	6400129	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	ISHIDA, MASAHIRO
<u>09511371</u>	6420197	150	02/23/2000	Semiconductor device and method of fabricating the same	ISHIDA, MASAHIRO
<u>09512780</u>	6423558	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC)	ISHIDA, MASAHIRO

				DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	
09532063	6593159	150	03/21/2000	SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	ISHIDA, MASAHIRO
09538135	6460001	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	ISHIDA, MASAHIRO
09538186	6735538	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	ISHIDA, MASAHIRO
09546881	6274518	150	04/10/2000	Method for producing a group III nitride compound semiconductor substrate	ISHIDA, MASAHIRO
09623944	Not Issued	161	09/12/2000	Pro-fragrance silicone polymer and compositions thereof	ISHIDA, MASAHIRO
09647908	6795496	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	ISHIDA, MASAHIRO
09650000	6598004	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	ISHIDA, MASAHIRO

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Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
09663700	6593765	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
09680054	6821805	150	10/05/2000	SEMICONDUCTOR DEVICE, SEMICONDUCTOR SUBSTRATE, AND MANUFACTURE METHOD	ISHIDA, MASAHIRO
09699077	6975978	150	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
09702278	Not Issued	160	10/30/2000	Method and apparatus for fault simulation of semiconductor integrated circuit	ISHIDA, MASAHIRO
09702695	6440790	250	11/01/2000	METHOD OF MAKING SEMICONDUCTOR DEVICE HAVING AN ISULATING FILM POSITIONED BETWEEN TWO SIMILARLY SHAPED CONDUCTIVE FILMS	ISHIDA, MASAHIRO
09703469	6775321	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
09722167	6525523	150	11/24/2000	JITTER MEASURMENT APPARATUS AND ITS METHOD	ISHIDA, MASAHIRO
09729424	6653663	150	12/05/2000	NITRIDE SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
09748436	6673702	150	12/26/2000	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
09758287	6358770	150	01/12/2001	METHOD FOR GROWING NITRIDE SEMICONDUCTOR	ISHIDA, MASAHIRO

				CRYSTALS, NITRIDE SEMICONDUCTOR DEVICE, AND METHOD FOR FABRICATING THE SAME	
09790908	6566231	150	02/23/2001	METHOD OF MANUFACTURING HIGH PERFORMANCE SEMICONDUCTOR DEVICE WITH REDUCED LATTICE DEFECTS IN THE ACTIVE REGION	ISHIDA, MASAHIRO
09811153	6922439	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
09813923	7127018	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	ISHIDA, MASAHIRO
09826295	6594595	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	ISHIDA, MASAHIRO
09864218	6569238	150	05/25/2001	APPARATUS AND METHOD FOR DEPOSITING SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
09876389	7185254	150	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
09880976	6461882	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
09882290	7203229	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
09921885	6562644	150	08/06/2001	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD	ISHIDA, MASAHIRO
09980891	6801049	150	12/03/2001	METHOD AND APPARATUS	ISHIDA,

				FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	MASAHIRO
<u>09986997</u>	Not Issued	161	11/13/2001	Method for fabricating semiconductor device having group III nitride	ISHIDA, MASAHIRO
<u>10032563</u>	6864158	150	01/02/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10033188</u>	6737852	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	ISHIDA, MASAHIRO
<u>10054844</u>	6649494	150	01/25/2002	MANUFACTURING METHOD OF COMPOUND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO
<u>10062512</u>	6562701	150	02/05/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	ISHIDA, MASAHIRO
<u>10100118</u>	6589857	150	03/19/2002	MANUFACTURING METHOD OF SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
<u>10118924</u>	6723165	150	04/10/2002	METHOD FOR FABRICATING GROUP III NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10134298</u>	7054358	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	ISHIDA, MASAHIRO
<u>10145144</u>	6750158	150	05/15/2002	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>10240182</u>	6990417	150	09/27/2002	Jitter estimating apparatus and estimating method	ISHIDA, MASAHIRO
<u>10249116</u>	6815726	150	03/17/2003	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	ISHIDA, MASAHIRO
<u>10265349</u>	Not Issued	161	10/04/2002	Measurement apparatus and measuring method	ISHIDA, MASAHIRO
<u>10405791</u>	6773948	150	04/02/2003	SEMICONDUCTOR LIGHT EMITTING DEVICE AND	ISHIDA, MASAHIRO

METHOD FOR PRODUCING THE SAME				
<u>10413995</u>	6905898	150	04/16/2003	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD
<u>10442301</u>	6887770	150	05/21/2003	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE
<u>10457362</u>	Not Issued	83	06/10/2003	Semiconductor wafer, semiconductor device, and methods for fabricating the same
<u>10459438</u>	6797991	150	06/12/2003	NITRIDE SEMICONDUCTOR DEVICE
<u>10531725</u>	Not Issued	71	04/18/2005	Pneumatic tire
<u>10532069</u>	Not Issued	71	04/21/2005	Pneumatic tire
<u>10711698</u>	Not Issued	161	09/30/2004	SEMICONDUCTOR DEVICE AND SEMICONDUCTOR SUBSTRATE, AND METHOD OF FABRICATING THE SAME
<u>10737716</u>	7136773	150	12/16/2003	TESTING APPARATUS AND TESTING METHOD
<u>10776926</u>	Not Issued	41	02/11/2004	Measuring apparatus and measuring method
<u>10779904</u>	Not Issued	25	02/17/2004	Method and apparatus for defect analysis of semiconductor integrated circuit
<u>10779905</u>	6828815	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT
<u>10824763</u>	Not Issued	30	04/14/2004	Testing apparatus and testing method
<u>10862904</u>	Not Issued	41	06/07/2004	Wideband signal analyzing apparatus, wideband period jitter analyzing apparatus, and wideband skew analyzing apparatus
<u>10896751</u>	Not	30	07/22/2004	Jitter measuring apparatus, jitter

	Issued			measuring method and PLL circuit	MASAHIRO
10921913	Not Issued	95	08/20/2004	MANUFACTURING METHOD FOR SEMICONDUCTOR DEVICE, SEMICONDUCTOR DEVICE AND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO

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Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>10925870</u>	Not Issued	30	08/25/2004	Measurement instrument and measurement method	ISHIDA, MASAHIRO
<u>10971716</u>	Not Issued	161	10/22/2004	Phase difference detecting apparatus	ISHIDA, MASAHIRO
<u>11056330</u>	Not Issued	93	02/11/2005	TEST APPARATUS AND TEST METHOD FOR TESTING A DEVICE UNDER TEST	ISHIDA, MASAHIRO
<u>11057707</u>	Not Issued	168	02/14/2005	Jitter measurement apparatus, jitter measurement method, and test apparatus	ISHIDA, MASAHIRO
<u>11060212</u>	Not Issued	30	02/17/2005	Apparatus for measuring jitter, method of measuring jitter and computer-readable medium storing a program thereof	ISHIDA, MASAHIRO
<u>11092804</u>	Not Issued	41	03/30/2005	Semiconductor substrate, method of manufacturing the semiconductor substrate, semiconductor device and pattern forming method	ISHIDA, MASAHIRO
<u>11122262</u>	Not Issued	30	05/04/2005	Apparatus for measuring jitter and method of measuring jitter	ISHIDA, MASAHIRO
<u>11137786</u>	Not Issued	30	05/25/2005	Apparatus for measuring jitter and method of measuring jitter	ISHIDA, MASAHIRO
<u>11238821</u>	Not Issued	93	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>11238822</u>	7225378	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>11239414</u>	7225377	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING	ISHIDA, MASAHIRO

SEMICONDUCTOR INTEGRATED CIRCUIT				
<u>11260665</u>	Not Issued	30	10/28/2005	Test apparatus, clock generator and electronic device
<u>11266471</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus background of the invention
<u>11266472</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus
<u>11362536</u>	Not Issued	41	02/27/2006	Measuring apparatus, measuring method, testing apparatus, testing method, and electronics device
<u>11371849</u>	Not Issued	25	03/10/2006	Calibration apparatus, calibration method, testing apparatus, and testing method
<u>11371939</u>	Not Issued	25	03/10/2006	Electronic device, testing apparatus, and testing method
<u>11378407</u>	Not Issued	30	03/17/2006	Jitter measurement apparatus, jitter measurement method, test apparatus and electronic device
<u>11390340</u>	Not Issued	41	03/28/2006	Jitter amplifier, jitter amplification method, electronic device, testing apparatus, and testing method
<u>11407136</u>	Not Issued	30	04/20/2006	Testing apparatus, testing method, jitter filtering circuit, and jitter filtering method
<u>11407588</u>	Not Issued	41	04/20/2006	Calibration apparatus, calibration method, testing apparatus, and testing method
<u>11535279</u>	Not Issued	30	09/26/2006	JITTER MEASUREMENT APPARATUS, JITTER MEASUREMENT METHOD, AND RECORDING MEDIUM
<u>11535296</u>	Not Issued	25	09/26/2006	DELAY CIRCUIT, JITTER INJECTION CIRCUIT, AND TEST APPARATUS
<u>11570042</u>	Not Issued	19	01/01/0001	TIMING GENERATOR AND SEMICONDUCTOR TESTING APPARATUS
<u>11581778</u>	Not Issued	30	10/16/2006	Jitter injection apparatus, jitter injection method, test apparatus, and communication chip

<u>11582142</u>	Not Issued	30	10/17/2006	Calibration apparatus, calibration method, and testing apparatus	ISHIDA, MASAHIRO
<u>11582143</u>	Not Issued	25	10/17/2006	Calibration apparatus, calibration method, and testing apparatus	ISHIDA, MASAHIRO
<u>11585526</u>	Not Issued	41	10/23/2006	Apparatus for and method of measuring clock skew	ISHIDA, MASAHIRO
<u>11609950</u>	Not Issued	20	12/13/2006	OSCILLATOR CIRCUIT, PLL CIRCUIT, SEMICONDUCTOR CHIP, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616009</u>	Not Issued	20	12/25/2006	SIGNAL GENERATOR CIRCUIT, JITTER INJECTION CIRCUIT, SEMICONDUCTOR CHIP AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616010</u>	Not Issued	20	12/25/2006	JITTER AMPLIFIER CIRCUIT, SIGNAL GENERATION CIRCUIT, SEMICONDUCTOR CHIP, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11616038</u>	Not Issued	16	12/26/2006	JITTER MEASUREMENT APPARATUS, ELECTRONIC DEVICE, AND TEST APPARATUS	ISHIDA, MASAHIRO
<u>11745889</u>	Not Issued	19	01/01/0001	MANUFACTURING METHOD FOR SEMICONDUCTOR DEVICE, SEMICONDUCTOR DEVICE AND SEMICONDUCTOR WAFER	ISHIDA, MASAHIRO
<u>29055374</u>	D390171	150	06/05/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29060588</u>	D392229	150	10/01/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29060763</u>	D387711	150	10/07/1996	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29107470</u>	RE37306	150	06/22/1999	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29150336</u>	D467535	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29150337</u>	D460402	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29211237</u>	D512014	150	08/13/2004	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<u>29211238</u>	D522962	150	08/13/2004	AUTOMOBILE TIRE	ISHIDA, MASAHIRO

<u>60277251</u>	Not Issued	159	03/20/2001	Apparatus and method for estimating probability of peak-to-peak value of clock skew	ISHIDA, MASAHIRO
<u>60545697</u>	Not Issued	159	02/18/2004	Frequency-domain based method for measuring deterministic jitter	ISHIDA, MASAHIRO
<u>60800391</u>	Not Issued	159	05/15/2006	Electrically-pumped (Ga,In,A1)N vertical-cavity surface-emitting laser	ISHIDA, MASAHIRO

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Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
06162201	Not Issued	161	06/23/1980	NOVEL SUBSTANCE THE69E AND PHARMACEUTICAL COMPOSITIONS CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
06352068	4543259	150	02/24/1982	NOVEL SUBSTANCE TH69E AND IMMUNOPOTENTIATOR CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
06654132	4607216	150	09/25/1984	APPARATUS FOR MEASUREMENT BY DIGITAL SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
06940058	4761634	150	12/10/1986	AD CONVERTING DEVICE	YAMAGUCHI, TAKAHIRO
07082231	4774454	150	08/06/1987	DISTORTION MEASURING SYSTEM METHOD UTILIZING SIGNAL SUPPRESSION	YAMAGUCHI, TAKAHIRO
07152339	5177254	150	02/04/1988	METHOD FOR PRODUCING AN UNSATURATED GLYCOL DIESTER	YAMAGUCHI, TAKAHIRO
07201684	4913955	150	06/02/1988	EPOXY RESIN LAMINATE	YAMAGUCHI, TAKAHIRO
07201685	4883708	150	06/02/1988	A METAL FOIL COVERED LAMINATE	YAMAGUCHI, TAKAHIRO
07251795	4914677	150	10/03/1988	DIGITAL LOCK-IN AMPLIFIER	YAMAGUCHI, TAKAHIRO
07271879	4885708	150	11/16/1988	APPARATUS AND METHOD FOR MEASURING FREQUENCY RESPONSE FUNCTION	YAMAGUCHI, TAKAHIRO
07401055	Not Issued	168	08/31/1989	NUMERICAL CONTROL METHOD	YAMAGUCHI, TAKAHIRO
07501139	5117368	150	03/29/1990	CONTROL DEVICE FOR TAPPING	YAMAGUCHI, TAKAHIRO

<u>07770404</u>	<u>5198984</u>	150	10/03/1991	NUMERICAL CONTROL METHOD FOR CORRECTING MACHINE TOOL PATH ERRORS	YAMAGUCHI, TAKAHIRO
<u>08363223</u>	Not Issued	161	12/23/1994	SUBSTITUTED CYCLIC AMINE COMPOUND, PRODUCTION PROCESS THEREOF AND PHARMACEUTICAL COMPOSITION FOR CIRCULATORY ORGAN USE CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>08575062</u>	<u>5728835</u>	150	12/19/1995	SUBSTITUTED CYCLIC AMINE COMPOUND, PRODUCTION PROCESS THEREOF AND PHARMACEUTICAL COMPOSITION FOR CIRCULATORY ORGAN USE CONTAINING THE SAME	YAMAGUCHI, TAKAHIRO
<u>08632131</u>	<u>5683753</u>	150	04/15/1996	METHOD OF PAINTING BUILDING BOARDS	YAMAGUCHI, TAKAHIRO
<u>08681502</u>	<u>5662968</u>	150	07/23/1996	METHOD OF PAINTING BUILDING BOARD BY SPRAY PAINTING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>08693598</u>	<u>5907316</u>	150	08/05/1996	METHOD OF AND APPARATUS FOR DISPLAYING HALFTONE IMAGES	YAMAGUCHI, TAKAHIRO
<u>08707032</u>	<u>6229316</u>	250	09/03/1996	MEASURING METHOD BY SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<u>08714409</u>	<u>6100939</u>	150	09/16/1996	TONE DISPLAY METHOD AND APPARATUS FOR DISPLAYING IMAGE SIGNAL	YAMAGUCHI, TAKAHIRO
<u>08883233</u>	<u>6529204</u>	150	06/26/1997	METHOD OF AND APPARATUS FOR DISPLAYING HALFTONE IMAGES	YAMAGUCHI, TAKAHIRO
<u>08944685</u>	<u>6147950</u>	150	10/07/1997	RECORDING AND REPRODUCING APPARATUS AND RECORDING AND REPRODUCING METHOD	YAMAGUCHI, TAKAHIRO
<u>09017881</u>	<u>6142581</u>	150	02/03/1998	HYDRAULIC CIRCUIT HAVING A ROTARY TYPE PUMP AND BRAKE APPARATUS FOR A VEHICLE PROVIDED WITH THE SAME	YAMAGUCHI, TAKAHIRO

<u>09063825</u>	6013826	250	04/22/1998	A METHOD FORMATION OF A CARBON-CARBON BOND	YAMAGUCHI, TAKAHIRO
<u>09077658</u>	6018504	150	09/30/1998	RECORDING DEVICE CAPABLE OF RECORDING BROADCAST SIGNALS AT A DESIRED TIME	YAMAGUCHI, TAKAHIRO
<u>09157272</u>	6326909	150	09/18/1998	EVALUATION SYSTEM FOR ANALOG-DIGITAL OR DIGITAL-ANALOG CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09165267</u>	Not Issued	161	10/01/1998	AUTOMATIC REMOTE ELECTRONIC INSTRUMENT CONNECTING SYSTEM	YAMAGUCHI, TAKAHIRO
<u>09166269</u>	Not Issued	161	10/05/1998	MEASURING SYSTEM	YAMAGUCHI, TAKAHIRO
<u>09166297</u>	6418391	150	10/05/1998	TESTING SYSTEM FOR PERFORMING AN OPERATION OF AN APPLICATION WHICH CONTROLS TESTING EQUIPMENT FOR TESTING A DEVICE UNDER TEST AND METHOD FOR CONTROLLING THE SAME	YAMAGUCHI, TAKAHIRO
<u>09166698</u>	Not Issued	161	10/05/1998	GUI PROCESSING SYSTEM FOR PERFORMING AN OPERATION OF AN APPLICATION WHICH CONTROLS TESTING EQUIPMENT	YAMAGUCHI, TAKAHIRO
<u>09170052</u>	6270169	150	10/13/1998	ROTARY PUMP AND BRAKING DEVICE USING SAME	YAMAGUCHI, TAKAHIRO
<u>09183644</u>	6177894	150	10/30/1998	EVALUATION SYSTEM AND METHOD FOR AD CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09194220</u>	6661839	150	11/20/1998	METHOD AND DEVICE FOR COMPRESSING AND EXPANDING DATA PATTERN	YAMAGUCHI, TAKAHIRO
<u>09246458</u>	6621860	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
<u>09248110</u>	6191571	250	02/11/1999	MEASURING METHOD BY SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<u>09251096</u>	6291979	150	02/16/1999	APPARATUS FOR AND	YAMAGUCHI,

				METHOD OF DETECTING A DELAY FAULT	TAKAHIRO
09299798	6442733	150	04/26/1999	FAILURE ANALYZING METHOD AND APPARATUS	YAMAGUCHI, TAKAHIRO
09408280	6687629	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
09412315	6273527	150	10/05/1999	ROTARY PUMP WITH BETTER FLUID SEALING STRUCTURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
09413818	6584236	150	10/07/1999	IMAGE PROCESSING APPARATUS AND METHOD FOR IMAGE PROCESSING	YAMAGUCHI, TAKAHIRO
09494321	6400129	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	YAMAGUCHI, TAKAHIRO
09512780	6423558	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	YAMAGUCHI, TAKAHIRO
09528720	Not Issued	161	03/20/2000	Measuring method by spectrum analyzer	YAMAGUCHI, TAKAHIRO
09538135	6460001	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	YAMAGUCHI, TAKAHIRO
09538186	6735538	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	YAMAGUCHI, TAKAHIRO
09634734	6333766	150	08/08/2000	Tone display method and apparatus for displaying image signal	YAMAGUCHI, TAKAHIRO
09647908	6795496	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	YAMAGUCHI, TAKAHIRO
09650000	6598004	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
09663700	6593765	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
09694680	6474751	150	10/24/2000	HYDRAULIC CIRCUIT	YAMAGUCHI,

				HAVING A ROTARY TYPE PUMP AND BRAKE APPARATUS FOR A VEHICLE PROVIDED WITH THE SAME	TAKAHIRO
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Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name
09697294	6478477	150	10/27/2000	PLANAR PACKAGED OPTICAL MODULE HAVING 1ST AND 2ND ADHESIVES WITH DIFFERENT GLASS-TRANSITION TEMPERATURES	YAMAGUCHI, TAKAHIRO
09699077	6975978	150	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
09702278	Not Issued	160	10/30/2000	Method and apparatus for fault simulation of semiconductor integrated circuit	YAMAGUCHI, TAKAHIRO
09703469	6775321	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
09722167	6525523	150	11/24/2000	JITTER MEASURMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
09811153	6922439	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
09813923	7127018	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	YAMAGUCHI, TAKAHIRO
09826295	6594595	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	YAMAGUCHI, TAKAHIRO
09835824	7035959	150	04/17/2001	ADAPTER FOR CONTROLLING A MEASURING DEVICE, A MEASURING DEVICE, A	YAMAGUCHI, TAKAHIRO

				CONTROLLER FOR A MEASURING DEVICE, A METHOD FOR PROCESSING MEASUREMENT AND A RECORDING MEDIUM	
<u>09876389</u>	7185254	150	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09880976</u>	6461882	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09882290</u>	7203229	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
<u>09897024</u>	6474752	150	07/03/2001	ROTARY PUMP AND BRAKING DEVICE USING SAME	YAMAGUCHI, TAKAHIRO
<u>09905882</u>	7031595	150	07/17/2001	DISK REPRODUCING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>09925230</u>	6476742	150	08/08/2001	EVALUATION SYSTEM FOR ANALOG-DIGITAL OR DIGITAL-ANALOG CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09980891</u>	6801049	150	12/03/2001	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09995402</u>	Not Issued	161	11/26/2001	Automatic remote electronic instrument connecting system and method	YAMAGUCHI, TAKAHIRO
<u>10033188</u>	6737852	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	YAMAGUCHI, TAKAHIRO
<u>10033533</u>	Not Issued	161	10/25/2001	GUI processing system for performing an operation of an application which controls testing equipment	YAMAGUCHI, TAKAHIRO
<u>10053882</u>	6715847	150	01/24/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10082307</u>	Not	164	02/26/2002	PLANAR PACKAGED	YAMAGUCHI,

	Issued			OPTICAL MODULE AND TRANSMISSION SUBSTRATE USING PLANAR PACKAGE OPTICAL MODULE	TAKAHIRO
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	YAMAGUCHI, TAKAHIRO
<u>10134298</u>	7054358	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	YAMAGUCHI, TAKAHIRO
<u>10205592</u>	Not Issued	71	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	YAMAGUCHI, TAKAHIRO
<u>10214443</u>	6749272	150	08/08/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10214472</u>	7193728	150	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	YAMAGUCHI, TAKAHIRO
<u>10240182</u>	6990417	150	09/27/2002	Jitter estimating apparatus and estimating method	YAMAGUCHI, TAKAHIRO
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	YAMAGUCHI, TAKAHIRO
<u>10265349</u>	Not Issued	161	10/04/2002	Measurement apparatus and measuring method	YAMAGUCHI, TAKAHIRO
<u>10279996</u>	6783193	150	10/25/2002	ROTARY PUMP AND BRAKING APPARATUS USING ROTARY PUMP	YAMAGUCHI, TAKAHIRO
<u>10298841</u>	Not Issued	41	11/18/2002	Relay apparatus and relay method suitable for performing communication to ensure quality of service	YAMAGUCHI, TAKAHIRO
<u>10369199</u>	7144091	150	02/20/2003	BRAKE APPARATUS WITH ORIFICES FOR RESTRICTING BRAKE FLUID PRESSURE PULSATION	YAMAGUCHI, TAKAHIRO
<u>10382993</u>	7020053	150	03/07/2003	OPTICAL DISC APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10453623</u>	6905321	150	06/04/2003	ROTARY PUMP FOR BRAKING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10463471</u>	Not	161	06/18/2003	Optical transmitter/receiver	YAMAGUCHI,

	Issued			module	TAKAHIRO
<u>10521942</u>	Not Issued	30	01/21/2005	Driver of compressor and refrigerator	YAMAGUCHI, TAKAHIRO
<u>10522217</u>	<u>7219522</u>	150	01/24/2005	OVAL CROSS SECTION METAL TUBE PRODUCING DEVICE AND PRODUCING METHOD	YAMAGUCHI, TAKAHIRO
<u>10546917</u>	Not Issued	30	08/25/2005	Association control apparatus, association control method and service association system	YAMAGUCHI, TAKAHIRO
<u>10553469</u>	Not Issued	30	10/17/2005	Electronic watermark-containing moving picture transmission system, electronic watermark-containing moving picture transmission method, information processing device, communication control device, electronic watermark-containing moving picture processing program, and storage medium containing electronic watermark-containing	YAMAGUCHI, TAKAHIRO
<u>10699345</u>	<u>7164642</u>	150	11/03/2003	OPTICAL DISK REPRODUCING APPARATUS AND METHOD FOR CONTROLLING SPINDLE MOTOR	YAMAGUCHI, TAKAHIRO
<u>10713280</u>	<u>7049608</u>	150	11/15/2003	POSITION DETECTION APPARATUS, POSITION DETECTION METHOD, ELECTRONIC PART CARRYING APPARATUS, AND ELECTRONIC BEAM EXPOSURE APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10737716</u>	<u>7136773</u>	150	12/16/2003	TESTING APPARATUS AND TESTING METHOD	YAMAGUCHI, TAKAHIRO
<u>10776926</u>	Not Issued	41	02/11/2004	Measuring apparatus and measuring method	YAMAGUCHI, TAKAHIRO
<u>10779904</u>	Not Issued	25	02/17/2004	Method and apparatus for defect analysis of semiconductor integrated circuit	YAMAGUCHI, TAKAHIRO
<u>10779905</u>	<u>6828815</u>	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>10824763</u>	Not	30	04/14/2004	Testing apparatus and testing	YAMAGUCHI,

	Issued			method	TAKAHIRO
<u>10862904</u>	Not Issued	41	06/07/2004	Wideband signal analyzing apparatus, wideband period jitter analyzing apparatus, and wideband skew analyzing apparatus	YAMAGUCHI, TAKAHIRO
<u>10896751</u>	Not Issued	30	07/22/2004	Jitter measuring apparatus, jitter measuring method and PLL circuit	YAMAGUCHI, TAKAHIRO
<u>10925870</u>	Not Issued	30	08/25/2004	Measurement instrument and measurement method	YAMAGUCHI, TAKAHIRO
<u>10971716</u>	Not Issued	161	10/22/2004	Phase difference detecting apparatus	YAMAGUCHI, TAKAHIRO

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Last Name = YAMAGUCHI

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Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>11056330</u>	Not Issued	93	02/11/2005	TEST APPARATUS AND TEST METHOD FOR TESTING A DEVICE UNDER TEST	YAMAGUCHI, TAKAHIRO
<u>11057707</u>	Not Issued	168	02/14/2005	Jitter measurement apparatus, jitter measurement method, and test apparatus	YAMAGUCHI, TAKAHIRO
<u>11060212</u>	Not Issued	30	02/17/2005	Apparatus for measuring jitter, method of measuring jitter and computer-readable medium storing a program thereof	YAMAGUCHI, TAKAHIRO
<u>11101350</u>	7167772	150	04/07/2005	MACHINING TIME CALCULATING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>11122262</u>	Not Issued	30	05/04/2005	Apparatus for measuring jitter and method of measuring jitter	YAMAGUCHI, TAKAHIRO
<u>11137786</u>	Not Issued	30	05/25/2005	Apparatus for measuring jitter and method of measuring jitter	YAMAGUCHI, TAKAHIRO
<u>11182018</u>	7193434	150	07/15/2005	SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>11182026</u>	Not Issued	41	07/15/2005	Semiconductor integrated circuit and manufacturing method of the same	YAMAGUCHI, TAKAHIRO
<u>11238821</u>	Not Issued	93	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>11238822</u>	7225378	150	09/28/2005	GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>11239414</u>	7225377	150	09/28/2005	GENERATING TEST PATTERNS USED IN	YAMAGUCHI, TAKAHIRO

TESTING SEMICONDUCTOR INTEGRATED CIRCUIT				
<u>11259059</u>	Not Issued	30	10/27/2005	Rotary pump for braking device
<u>11260665</u>	Not Issued	30	10/28/2005	Test apparatus, clock generator and electronic device
<u>11266471</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus background of the invention
<u>11266472</u>	Not Issued	30	11/04/2005	Jitter measuring apparatus, jitter measuring method and test apparatus
<u>11334752</u>	Not Issued	30	01/19/2006	Position detection apparatus, position detection method, testing apparatus, and camera module manufacturing apparatus
<u>11337565</u>	Not Issued	30	01/24/2006	Electronic device and display control method
<u>11340870</u>	Not Issued	30	01/27/2006	Residue number system arithmetic operating system, scaling operator, scaling operation method and program and recording medium of the same
<u>11362536</u>	Not Issued	41	02/27/2006	Measuring apparatus, measuring method, testing apparatus, testing method, and electronics device
<u>11371849</u>	Not Issued	25	03/10/2006	Calibration apparatus, calibration method, testing apparatus, and testing method
<u>11371939</u>	Not Issued	25	03/10/2006	Electronic device, testing apparatus, and testing method
<u>11378407</u>	Not Issued	30	03/17/2006	Jitter measurement apparatus, jitter measurement method, test apparatus and electronic device
<u>11390340</u>	Not Issued	41	03/28/2006	Jitter amplifier, jitter amplification method, electronic device, testing apparatus, and testing method
<u>11407136</u>	Not Issued	30	04/20/2006	Testing apparatus, testing method, jitter filtering circuit, and jitter filtering method
<u>11463644</u>	Not	19	08/10/2006	PROBABILITY DENSITY
				YAMAGUCHI,

	Issued			FUNCTION SEPARATING APPARATUS, PROBABILITY DENSITY FUNCTION SEPARATING METHOD, TESTING APPARATUS, BIT ERROR RATE MEASURING APPARATUS, ELECTRONIC DEVICE, AND PROGRAM	TAKAHIRO
<u>11475056</u>	Not Issued	25	06/27/2006	Spray nozzle	YAMAGUCHI, TAKAHIRO
<u>11535279</u>	Not Issued	30	09/26/2006	JITTER MEASUREMENT APPARATUS, JITTER MEASUREMENT METHOD, AND RECORDING MEDIUM	YAMAGUCHI, TAKAHIRO
<u>11585526</u>	Not Issued	41	10/23/2006	Apparatus for and method of measuring clock skew	YAMAGUCHI, TAKAHIRO
<u>11589237</u>	Not Issued	25	10/30/2006	Vehicular brake device	YAMAGUCHI, TAKAHIRO
<u>11668098</u>	Not Issued	20	01/29/2007	OPTICAL PICKUP	YAMAGUCHI, TAKAHIRO
<u>11688877</u>	Not Issued	19	03/21/2007	PROBABILITY DENSITY FUNCTION SEPARATING APPARATUS, PROBABILITY DENSITY FUNCTION SEPARATING METHOD, NOISE SEPARATING APPARATUS, NOISE SEPARATING METHOD, TESTING APPARATUS, TESTING METHOD, CALCULATING APPARATUS, CALCULATING METHOD, PROGRAM, AND RECORDING MEDIUM	YAMAGUCHI, TAKAHIRO
<u>11727589</u>	Not Issued	25	03/27/2007	Pump device	YAMAGUCHI, TAKAHIRO
<u>60545697</u>	Not Issued	159	02/18/2004	Frequency-domain based method for measuring deterministic jitter	YAMAGUCHI, TAKAHIRO
<u>60783820</u>	Not Issued	159	03/21/2006	Probability density function separating apparatus, probability density function separating method, noise separating apparatus, noise separating method, testing apparatus, testing method, calculating apparatus,	YAMAGUCHI, TAKAHIRO

				calculating method, program, and recording medium	
60894458	Not Issued	20	03/13/2007	TEST APPARATUS.	YAMAGUCHI, TAKAHIRO

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Last Name = SOMA

First Name = MANI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
09043659	5980246	150	03/24/1998	ORTHODONTICS HEADGEAR COMPLIANCE MONITOR	SOMA, MANI
09246458	6621860	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
09251096	6291979	150	02/16/1999	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT	SOMA, MANI
09408280	6687629	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
09494321	6400129	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	SOMA, MANI
09512780	6423558	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	SOMA, MANI
09538135	6460001	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	SOMA, MANI
09538186	6735538	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	SOMA, MANI
09647908	6795496	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	SOMA, MANI
09650000	6598004	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	SOMA, MANI
09669487	6885700	150	09/25/2000	CHARGE-BASED FREQUENCY	SOMA, MANI

				MEASUREMENT BIST	
<u>09703469</u>	<u>6775321</u>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<u>09722167</u>	<u>6525523</u>	150	11/24/2000	JITTER MEASURMENT APPARATUS AND ITS METHOD	SOMA, MANI
<u>09811153</u>	<u>6922439</u>	150	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>09813923</u>	<u>7127018</u>	150	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	SOMA, MANI
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	SOMA, MANI
<u>09882290</u>	<u>7203229</u>	150	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	SOMA, MANI
<u>10082563</u>	Not Issued	61	02/23/2002	Probability estimating apparatus and method for peak-to-peak clock skews	SOMA, MANI
<u>10134298</u>	<u>7054358</u>	150	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	SOMA, MANI
<u>10205592</u>	Not Issued	71	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	SOMA, MANI
<u>10214472</u>	<u>7193728</u>	150	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	SOMA, MANI
<u>10240182</u>	<u>6990417</u>	150	09/27/2002	Jitter estimating apparatus and estimating method	SOMA, MANI
<u>10260724</u>	Not Issued	71	09/30/2002	Jitter measurement apparatus and jitter measurement method	SOMA, MANI
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